Applicant(s)/Patent Under Application/Control No. Reexamination 10/695,174 NAM ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2616 PHUC H. TRAN **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 370/460 Α US-2002/0118700 08-2002 Bruckman, Leon 370/403 US-2002/0018481 02-2002 Mor et al. В С US-D US-US-Ε US-F US-G US-Н US-US-US-Κ US-L US-FOREIGN PATENT DOCUMENTS Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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